

Notice of References Cited	Application/Control No. 09/903,650		Applicant(s)/Patent Under Reexamination YOON ET AL.	
	Examiner Justin E. Shepard		Art Unit 2623	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,724,521	03-1998	Dedrick, Rick	705/26
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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